

Excellent Integrated System Limited

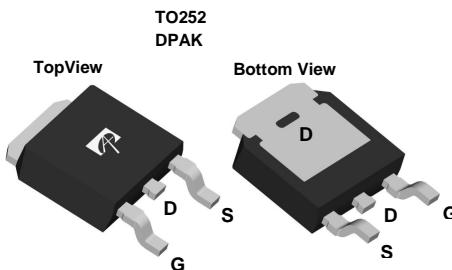
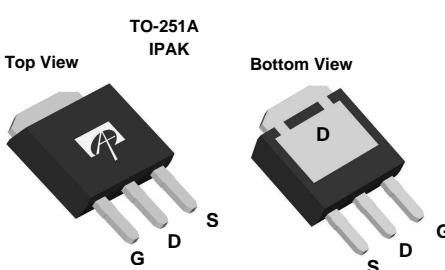
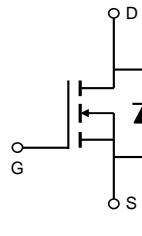
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[AOI482](#)

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 ALPHA & OMEGA SEMICONDUCTOR		AOD482/AOI482 <i>100V N-Channel MOSFET</i>			
General Description		Product Summary			
<p>The AOD482/AOI482 combines advanced trench MOSFET technology with a low resistance package to provide extremely low $R_{DS(ON)}$. This device is ideal for boost converters and synchronous rectifiers for consumer, telecom, industrial power supplies and LED backlighting.</p>		V_{DS} 100V I_D (at $V_{GS}=10V$) 32A $R_{DS(ON)}$ (at $V_{GS}=10V$) $< 37m\Omega$ $R_{DS(ON)}$ (at $V_{GS} = 4.5V$) $< 42m\Omega$ 100% UIS Tested 100% R_g Tested			
					
					
					
Absolute Maximum Ratings $T_A=25^\circ C$ unless otherwise noted					
Parameter	Symbol	Maximum	Units		
Drain-Source Voltage	V_{DS}	100	V		
Gate-Source Voltage	V_{GS}	± 20	V		
Continuous Drain Current ^A	I_D	32	A		
$T_C=100^\circ C$		22			
Pulsed Drain Current ^C	I_{DM}	70	A		
Continuous Drain Current	I_{DSM}	5			
$T_A=25^\circ C$		4	A		
$T_A=70^\circ C$					
Avalanche Current ^C	I_{AS}, I_{AR}	35	A		
Avalanche energy $L=0.1mH$ ^C	E_{AS}, E_{AR}	61	mJ		
Power Dissipation ^B	P_D	100	W		
$T_C=100^\circ C$		50			
Power Dissipation ^A	P_{DSM}	2.5	W		
$T_A=70^\circ C$		1.6			
Junction and Storage Temperature Range	T_J, T_{STG}	-55 to 175	°C		
Thermal Characteristics					
Parameter	Symbol	Typ	Max	Units	
Maximum Junction-to-Ambient ^A $t \leq 10s$	$R_{\theta JA}$	14.2	20	°C/W	
Maximum Junction-to-Ambient ^{AD} Steady-State	$R_{\theta JA}$	39	50	°C/W	
Maximum Junction-to-Case	$R_{\theta JC}$	0.8	1.5	°C/W	



AOD482/AOI482

Electrical Characteristics ($T_J=25^\circ\text{C}$ unless otherwise noted)

Symbol	Parameter	Conditions	Min	Typ	Max	Units
STATIC PARAMETERS						
BV_{DSS}	Drain-Source Breakdown Voltage	$I_D=250\mu\text{A}, V_{GS}=0\text{V}$	100			V
I_{DSS}	Zero Gate Voltage Drain Current	$V_{DS}=100\text{V}, V_{GS}=0\text{V}$			1	μA
I_{GSS}	Gate-Body leakage current	$V_{DS}=0\text{V}, V_{GS}=\pm 20\text{V}$			5	nA
$V_{GS(\text{th})}$	Gate Threshold Voltage	$V_{DS}=V_{GS}, I_D=250\mu\text{A}$	1.6	2.1	2.7	V
$I_{D(\text{ON})}$	On state drain current	$V_{GS}=10\text{V}, V_{DS}=5\text{V}$	70			A
$R_{DS(\text{ON})}$	Static Drain-Source On-Resistance	$V_{GS}=10\text{V}, I_D=10\text{A}$	30	37		$\text{m}\Omega$
		$T_J=125^\circ\text{C}$	63	76		
g_{FS}	Forward Transconductance	$V_{DS}=5\text{V}, I_D=10\text{A}$	32	42		$\text{m}\Omega$
V_{SD}	Diode Forward Voltage	$I_S=1\text{A}, V_{GS}=0\text{V}$	0.7	1		V
I_S	Maximum Body-Diode Continuous Current				54	A
DYNAMIC PARAMETERS						
C_{iss}	Input Capacitance	$V_{GS}=0\text{V}, V_{DS}=50\text{V}, f=1\text{MHz}$	1300	1630	2000	pF
C_{oss}	Output Capacitance		70	100	130	pF
C_{rss}	Reverse Transfer Capacitance		30	50	70	pF
R_g	Gate resistance	$V_{GS}=0\text{V}, V_{DS}=0\text{V}, f=1\text{MHz}$	0.3	0.75	1.1	Ω
SWITCHING PARAMETERS						
$Q_g(10\text{V})$	Total Gate Charge	$V_{GS}=10\text{V}, V_{DS}=50\text{V}, I_D=10\text{A}$	26	34	44	nC
$Q_g(4.5\text{V})$	Total Gate Charge		14	18	22	nC
Q_{gs}	Gate Source Charge		4	6	8	nC
Q_{gd}	Gate Drain Charge		5	9	13	nC
$t_{D(\text{on})}$	Turn-On Delay Time	$V_{GS}=10\text{V}, V_{DS}=50\text{V}, R_L=5\Omega, R_{\text{GEN}}=3\Omega$		7		ns
t_r	Turn-On Rise Time			7		ns
$t_{D(\text{off})}$	Turn-Off Delay Time			29		ns
t_f	Turn-Off Fall Time			7		ns
t_{rr}	Body Diode Reverse Recovery Time	$I_F=10\text{A}, dI/dt=500\text{A}/\mu\text{s}$	22	32	42	ns
Q_{rr}	Body Diode Reverse Recovery Charge	$I_F=10\text{A}, dI/dt=500\text{A}/\mu\text{s}$	140	200	260	nC

A. The value of R_{DSM} is measured with the device mounted on 1in² FR-4 board with 2oz. Copper, in a still air environment with $T_A=25^\circ\text{C}$. The Power dissipation P_{DSM} is based on R_{DSM} and the maximum allowed junction temperature of 150°C. The value in any given application depends on the user's specific board design, and the maximum temperature of 175°C may be used if the PCB allows it.

B. The power dissipation P_D is based on $T_{J(\text{MAX})}=175^\circ\text{C}$, using junction-to-case thermal resistance, and is more useful in setting the upper dissipation limit for cases where additional heatsinking is used.

C. Repetitive rating, pulse width limited by junction temperature $T_{J(\text{MAX})}=175^\circ\text{C}$. Ratings are based on low frequency and duty cycles to keep initial $T_J=25^\circ\text{C}$.

D. The R_{JA} is the sum of the thermal impedance from junction to case R_{JC} and case to ambient.

E. The static characteristics in Figures 1 to 6 are obtained using <300μs pulses, duty cycle 0.5% max.

F. These curves are based on the junction-to-case thermal impedance which is measured with the device mounted to a large heatsink, assuming a maximum junction temperature of $T_{J(\text{MAX})}=175^\circ\text{C}$. The SOA curve provides a single pulse rating.

G. The maximum current rating is package limited.

H. These tests are performed with the device mounted on 1 in² FR-4 board with 2oz. Copper, in a still air environment with $T_A=25^\circ\text{C}$.

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AOD482/AOI482

TYPICAL ELECTRICAL AND THERMAL CHARACTERISTICS

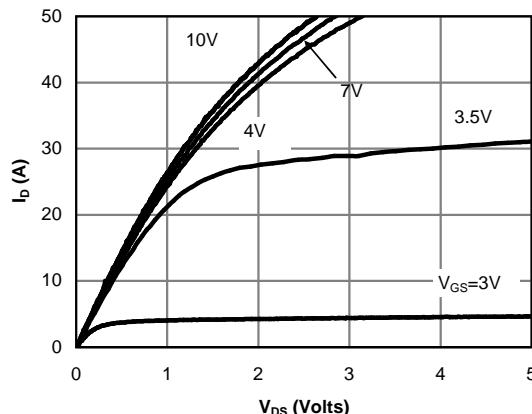


Fig 1: On-Region Characteristics (Note E)

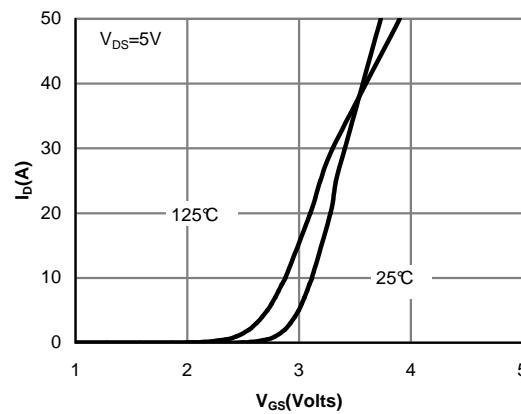


Figure 2: Transfer Characteristics (Note E)

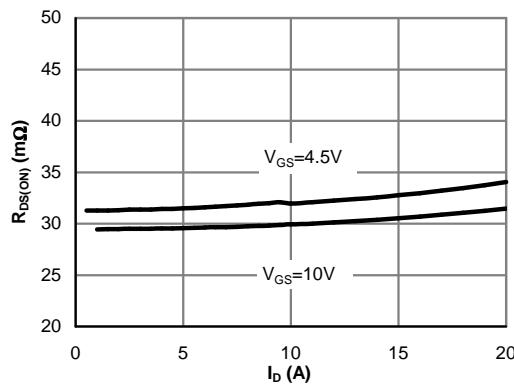


Figure 3: On-Resistance vs. Drain Current and Gate Voltage (Note E)

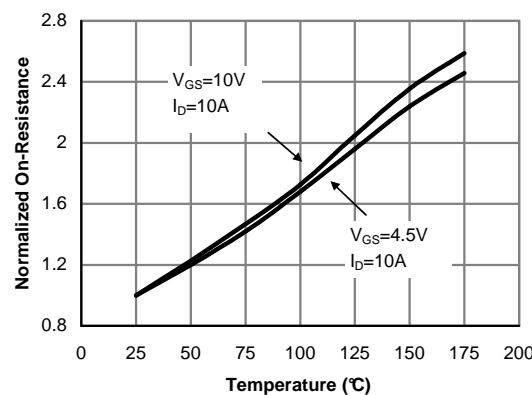


Figure 4: On-Resistance vs. Junction Temperature (Note E)

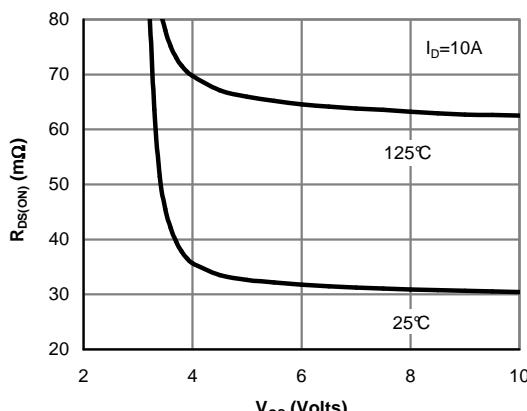


Figure 5: On-Resistance vs. Gate-Source Voltage (Note E)

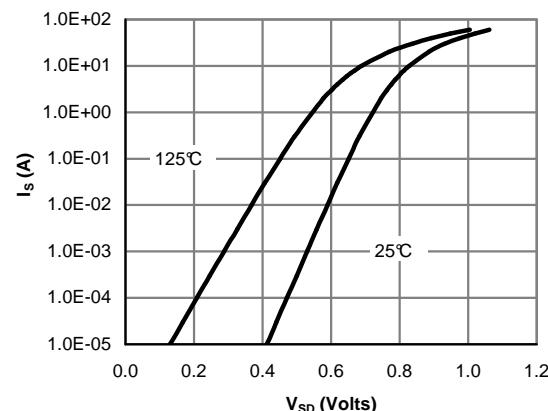
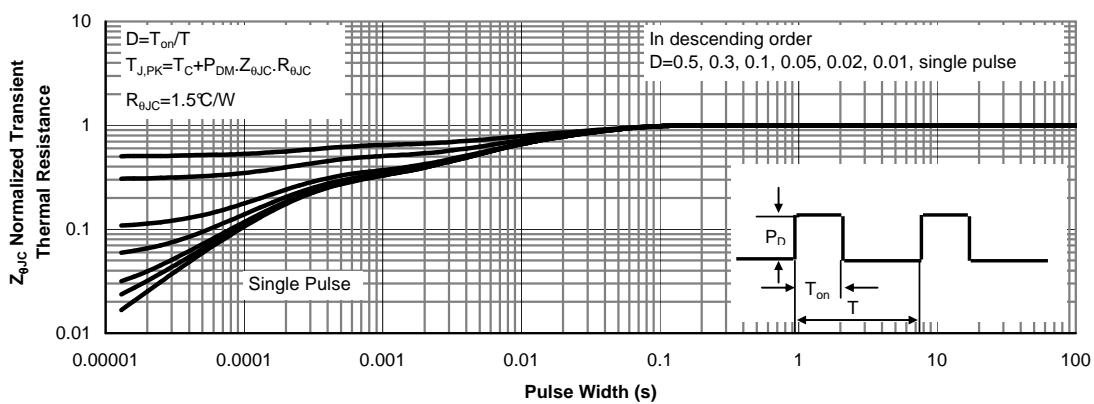
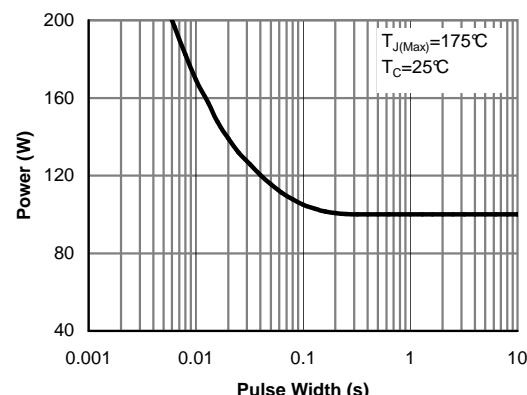
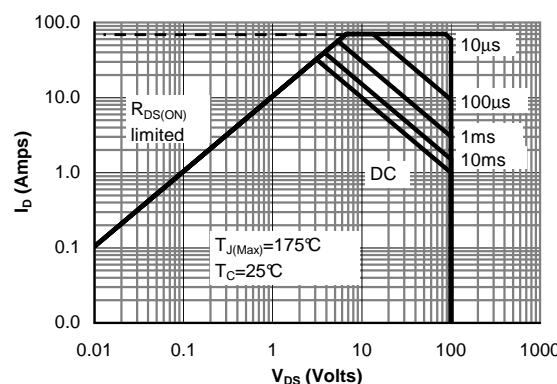
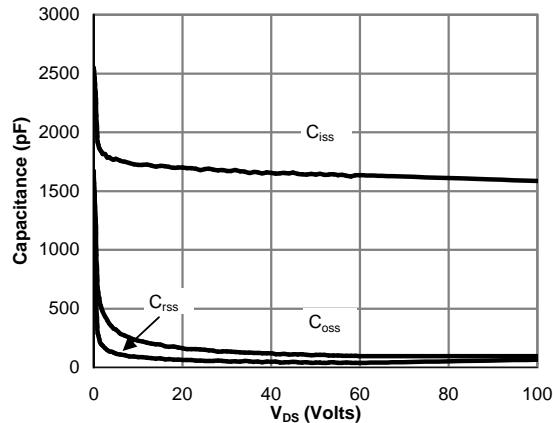
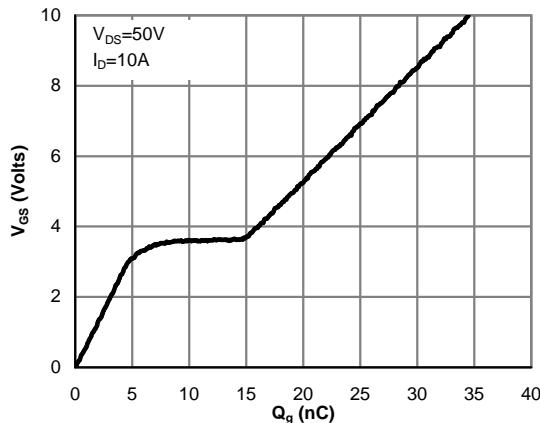


Figure 6: Body-Diode Characteristics (Note E)



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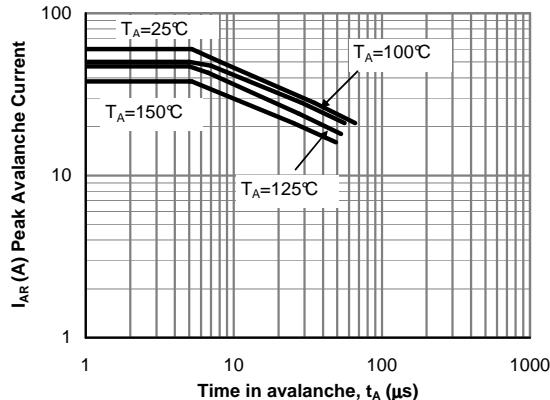


Figure 12: Single Pulse Avalanche capability
(Note C)

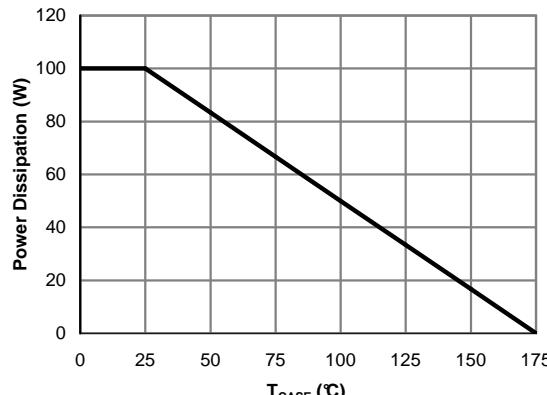


Figure 13: Power De-rating (Note F)

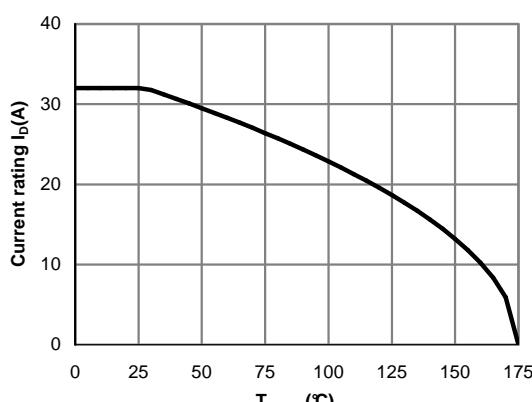


Figure 14: Current De-rating (Note F)

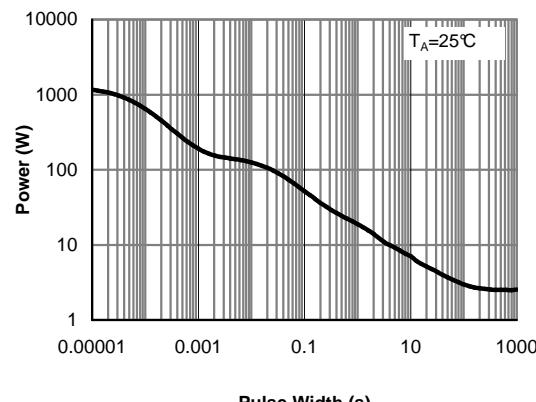


Figure 15: Single Pulse Power Rating Junction-to-Ambient (Note H)

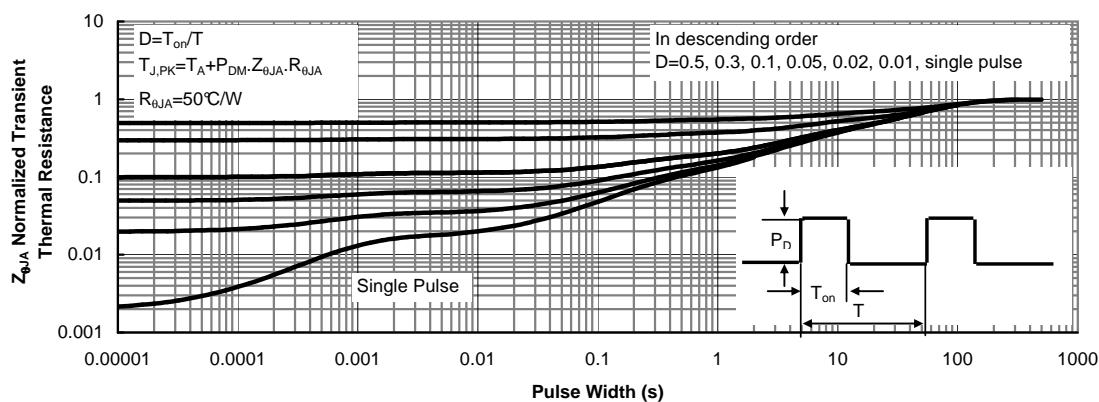
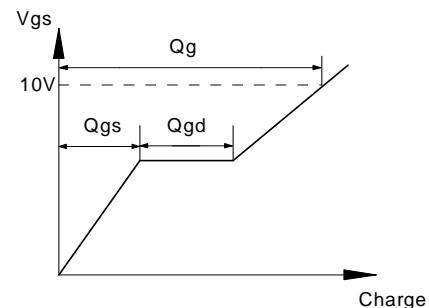
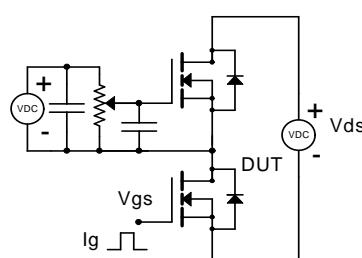


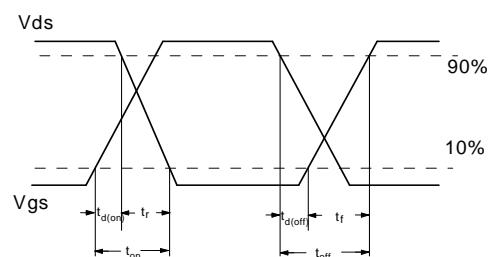
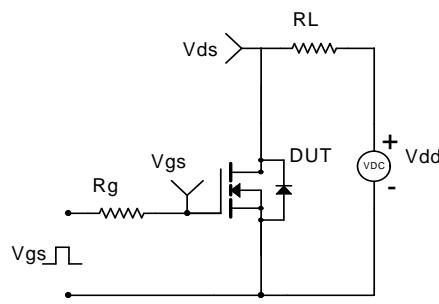
Figure 16: Normalized Maximum Transient Thermal Impedance (Note H)



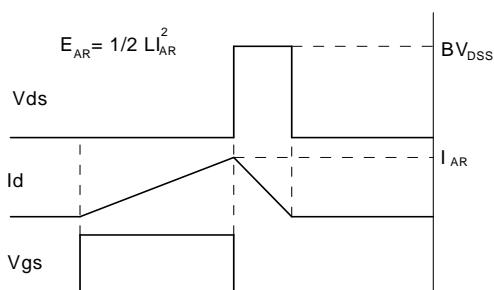
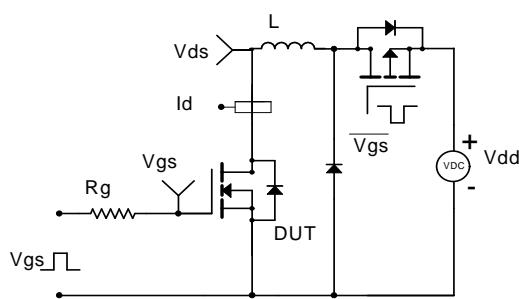
Gate Charge Test Circuit & Waveform



Resistive Switching Test Circuit & Waveforms



Unclamped Inductive Switching (UIS) Test Circuit & Waveforms



Diode Recovery Test Circuit & Waveforms

